

Search Notes

Application/Control No.

10/026,172

Examiner

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Applicant(s)/Patent under
Reexamination

FUJISAWA ET AL.

Art Unit

2681

SEARCHED

Class	Subclass	Date	Examiner
455	88	6/6/2005	PD
368	13	3/5/2006	PD
702	179	1/31/2006	PD
340	5.61	1/31/2006	PD
360	10	1/31/2006	PD
702	179	1/31/2006	PD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/31/2005	PD
EAST	6/2/2005	PD
EAST	6/3/2005	PD
EAST	1/31/2006	PD
EAST	3/5/2006	PD